| Parameter | Rating | Units |
| :--- | :---: | :---: |
| Blocking Voltage | 350 | $\mathrm{~V}_{\mathrm{P}}$ |
| Load Current | 120 | $\mathrm{~mA}_{\mathrm{rms}} / \mathrm{mA}_{\mathrm{DC}}$ |
| On-Resistance (max) | 30 | $\Omega$ |
| LED Current to operate | 2 | mA |

## Features

- $1500 \mathrm{~V}_{\text {rms }}$ Input/Output Isolation
- Small 8-Pin SOIC Package
- No EMI/RFI Generation
- Immune to radiated EM fields
- Tape \& Reel Version Available
- Flammability Rating UL 94 V-0


## Applications

- Telecommunication
- Security
- Passive Infrared Detectors (PIR)
- Data Signalling
- Sensor Circuitry
- Instrumentation
- Multiplexers
- Data Acquisition
- Electronic Switching
- I/O Subsystems
- Medical Equipment—Patient/Equipment Isolation
- Industrial Controls


## Pin Configuration



## Description

The CPC2330N is a miniature device with two independent solid state relays, one normally-open (1-Form-A) and the other normally-closed (1-Form-B), in an 8-pin SOIC package with $1500 \mathrm{~V}_{\text {rms }}$ of input to output isolation.

The optically coupled outputs, which use IXYS Integrated Circuits' patented OptoMOS architecture, are controlled by a highly efficient infrared LED.

Using IXYS Integrated Circuits' state of the art, double-molded vertical construction packaging, the CPC2330N is ideal for replacing larger, less-reliable reed and electromechanical relays.

## Approvals

- UL Recognized Component: File E76270
- TUV EN 62368-1: Certificate \# B 0826670008


## Ordering Information

| Part \# | Description |
| :--- | :--- |
| CPC2330N | 8-Pin SOIC (50/tube) |
| CPC2330NTR | 8-Pin SOIC (2000/reel) |


| Switching Characteristics of | Switching Characteristics of <br> Normally-Open Devices |
| :---: | :---: |
| Normally-Closed Devices |  |


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## Absolute Maximum Ratings @ $25^{\circ} \mathrm{C}$

| Parameter | Ratings | Units |
| :--- | :---: | :---: |
| Blocking Voltage | 350 | $\mathrm{~V}_{\mathrm{p}}$ |
| Reverse Input Voltage | 5 | V |
| Input Control Current <br> Peak (10ms) | 50 | mA |
|  | 1 | A |
| Total Power Dissipation ${ }^{1}$ | 600 | mW |
| Isolation Voltage, Input to Output | 1500 | $\mathrm{~V}_{\text {rms }}$ |
| ESD Rating, Human Body Model | 8 | kV |
| Operational Temperature, Ambient | -40 to +85 | ${ }^{\circ} \mathrm{C}$ |
| Storage Temperature | -40 to +125 | ${ }^{\circ} \mathrm{C}$ |
| Soldering Temperature (10 Seconds) | 260 | ${ }^{\circ} \mathrm{C}$ |

Derate linearly $5 \mathrm{~mW} /{ }^{\circ} \mathrm{C}$

Absolute Maximum Ratings are stress ratings. Stresses in excess of these ratings can cause permanent damage to the device. Functional operation of the device at conditions beyond those indicated in the operational sections of this data sheet is not implied.

Typical values are characteristic of the device at $+25^{\circ} \mathrm{C}$, and are the result of engineering evaluations. They are provided for information purposes only, and are not part of the manufacturing testing requirements.

## Electrical Characteristics @ $25^{\circ} \mathrm{C}$

| Parameter | Conditions | Symbol | Min | Typ | Max | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Output Characteristics |  |  |  |  |  |  |
| Blocking Voltage | $\mathrm{I}_{\mathrm{L}}=1 \mu \mathrm{~A}$ | $\mathrm{V}_{\text {DRM }}$ | 350 | - | - | V |
| Load Current Form-A, Continuous ${ }^{1}$ Form-B, Continuous ${ }^{1}$ | $\begin{aligned} & \mathrm{I}_{\mathrm{F}}=2 \mathrm{~mA} \\ & \mathrm{I}_{\mathrm{F}}=0 \mathrm{~mA} \end{aligned}$ | $I_{L}$ | - | - | 120 | $m A_{\text {rms }} / \mathrm{mA}_{\text {DC }}$ |
| Peak | $t=10 \mathrm{~ms}$ | LPPK | - | - | $\pm 350$ | $m A_{p}$ |
| On-Resistance ${ }^{2}$ | $\mathrm{I}_{\mathrm{L}}=120 \mathrm{~mA}$ | $\mathrm{R}_{\mathrm{ON}}$ | - | - | 30 | $\Omega$ |
| Switching Speeds <br> Turn-On <br> Turn-Off | $\mathrm{I}_{\mathrm{F}}=5 \mathrm{~mA}, \mathrm{~V}_{\mathrm{L}}=10 \mathrm{~V}$ | $t_{\text {on }}$ $\mathrm{t}_{\text {off }}$ | - | $\stackrel{-}{-}$ | 3 | ms |
| Off-State Leakage Current <br> Form-A <br> Form-B | $\begin{aligned} & I_{F}=0 \mathrm{~mA}, \mathrm{~V}_{\mathrm{L}}=350 \mathrm{~V}_{\mathrm{P}} \\ & \mathrm{I}_{\mathrm{F}}=\mathrm{mA}, \mathrm{~V}_{\mathrm{L}}=300 \mathrm{~V}_{\mathrm{P}} \end{aligned}$ | $\mathrm{l}_{\text {LEAK }}$ | - | 0.001 2 | 1 | $\mu \mathrm{A}$ |
| Output Capacitance <br> Form-A <br> Form-B | $\begin{aligned} & \mathrm{I}_{\mathrm{F}}=0 \mathrm{~mA}, \mathrm{~V}_{\mathrm{L}}=50 \mathrm{~V}, \mathrm{f}=1 \mathrm{MHz} \\ & \mathrm{I}_{\mathrm{F}}=2 \mathrm{~mA}, \mathrm{~V}_{\mathrm{L}}=50 \mathrm{~V}, \mathrm{MHz} \end{aligned}$ | $\mathrm{C}_{\text {OUT }}$ | - | 9 6 | - | pF |
| Input Characteristics |  |  |  |  |  |  |
| Input Control Current to Activate ${ }^{3}$ | $\mathrm{I}_{\mathrm{L}}=120 \mathrm{~mA}$ | $I_{F}$ | - | - | 2 | mA |
| Input Control Current to Deactivate | - | $I_{\text {F }}$ | 0.1 | - | - | mA |
| Input Voltage Drop | $\mathrm{I}_{\mathrm{F}}=5 \mathrm{~mA}$ | $V_{F}$ | 0.9 | 1.36 | 1.5 | V |
| Reverse Input Current | $\mathrm{V}_{\mathrm{R}}=5 \mathrm{~V}$ | $I_{\text {R }}$ | - | - | 10 | $\mu \mathrm{A}$ |
| Common Characteristics |  |  |  |  |  |  |
| Capacitance, Input to Output | $\mathrm{V}_{10}=0 \mathrm{~V}, \mathrm{f}=1 \mathrm{MHz}$ | $\mathrm{C}_{10}$ | - | 1 | - | pF |

[^0]
## Common Performance Data*




## FORM-A Performance Data*





[^1]
## FORM-A Performance Data (Cont.)*


*Unless otherwise noted, data presented in these graphs is typical of device operation at $25^{\circ} \mathrm{C}$

FORM-B Performance Data*

*Unless otherwise noted, data presented in these graphs is typical of device operation at $25^{\circ} \mathrm{C}$.

FORM-B PERFORMANCE DATA (Cont.)*





## Manufacturing Information

Moisture Sensitivity

(0)
All plastic encapsulated semiconductor packages are susceptible to moisture ingression. IXYS Integrated Circuits classifies its plastic encapsulated devices for moisture sensitivity according to the latest version of the joint industry standard, IPC/JEDEC J-STD-020, in force at the time of product evaluation. We test all of our products to the maximum conditions set forth in the standard, and guarantee proper operation of our devices when handled according to the limitations and information in that standard as well as to any limitations set forth in the information or standards referenced below.

Failure to adhere to the warnings or limitations as established by the listed specifications could result in reduced product performance, reduction of operable life, and/or reduction of overall reliability.

This product carries a Moisture Sensitivity Level (MSL) classification as shown below, and should be handled according to the requirements of the latest version of the joint industry standard IPC/JEDEC J-STD-033.

| Device | Moisture Sensitivity Level (MSL) Classification |
| :---: | :---: |
| CPC2330N | MSL 3 |

## ESD Sensitivity

This product is ESD Sensitive, and should be handled according to the industry standard JESD-625.

## Soldering Profile

Provided in the table below is the IPC/JEDEC J-STD-020 Classification Temperature ( $\mathrm{T}_{\mathrm{C}}$ ) and the maximum dwell time the body temperature of these surface mount devices may be $\left(T_{C}-5\right)^{\circ} \mathrm{C}$ or greater. The Classification Temperature sets the Maximum Body Temperature allowed for these devices during reflow soldering processes.

| Device | Classification Temperature $\left(T_{\mathrm{c}}\right)$ | Dwell Time $\left(\mathrm{t}_{\mathrm{p}}\right)$ | Max Reflow Cycles |
| :---: | :---: | :---: | :---: |
| CPC2330N | $260^{\circ} \mathrm{C}$ | 30 seconds | 3 |

## Board Wash

IXYS Integrated Circuits recommends the use of no-clean flux formulations. Board washing to reduce or remove flux residue following the solder reflow process is acceptable provided proper precautions are taken to prevent damage to the device. These precautions include but are not limited to: using a low pressure wash and providing a follow up bake cycle sufficient to remove any moisture trapped within the device due to the washing process. Due to the variability of the wash parameters used to clean the board, determination of the bake temperature and duration necessary to remove the moisture trapped within the package is the responsibility of the user (assembler). Cleaning or drying methods that employ ultrasonic energy may damage the device and should not be used. Additionally, the device must not be exposed to halide flux or solvents.
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## Mechanical Dimensions

## CPC2330N



Note:

1. Lead dimensions do not include plating: 1000 microinches max.

## CPC2330NTR Tape \& Reel



For additional information please visit our website at: https://www.ixysic.com

[^2]
## Mouser Electronics

Authorized Distributor

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IXYS:
CPC2330N CPC2330NTR


[^0]:    1 Load current derates linearly from $120 \mathrm{~mA} @ 25^{\circ} \mathrm{C}$ to $60 \mathrm{~mA} @ 85^{\circ} \mathrm{C}$, and must be derated for both poles operating simultaneously.
    2 Measurement taken within 1 second of on-time.
    3 For applications requiring high temperature operation (greater than $60^{\circ} \mathrm{C}$ ) a minimum LED drive current of 4 mA is recommended.

[^1]:    *Unless otherwise noted, data presented in these graphs is typical of device operation at $25^{\circ} \mathrm{C}$.

[^2]:    Disclaimer Notice - Information furnished is believed to be accurate and reliable. However, users should independently evaluate the suitability of and test each product selected for their own applications. Littelfuse products are not designed for, and may not be used in, all applications.
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